

Notice of References Cited	Application/Control No. 10/056,038	Applicant(s)/Patent Under Reexamination HAYAKAWA, TOSHIRO	
	Examiner Tuan N Nguyen	Art Unit 2828	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,656,641	04-1987	Scifres et al.	372/103
	B	US-4,464,021	08-1984	Brown et al.	359/243
	C	US-5,864,523	01-1999	Yoshizawa, Takashi	369/44.23
	D	US-6,242,328	06-2001	Shin, Hyun-eoi	438/518
	E	US-6,345,063	02-2002	Bour et al.	372/45
	F	US-2003/0169410	09-2003	Matsumoto et al.	355/53
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.